

**Search Notes**

Application/Control No.

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Examiner

Trinh T. Nguyen

Applicant(s)/Patent under  
Reexamination

DAY ET AL.

Art Unit

3644

**SEARCHED**

Class	Subclass	Date	Examiner
210	221.2 167.26	4/23/2010	TTN
updated	searches		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR